Search Notes		

•	Application/Control No.	Applicant(s)/Patent under Reexamination	_
	10/633,386	BENJAMIN ET AL.	
	Examiner	Art Unit	
	Charles H. Nolan, Jr.	2854	

	SEARCHED			
Class	Subclass	Date	Examiner	
Above	updated	4/27/2005	CHN	
702	117	4/27/2005	CHN	
And John Millian				

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
324	763	4/27/2005	CHN	
702	117	4/27/2005	CHN	

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